

Notice of References Cited	Application/Control No. 10/530,739		Applicant(s)/Patent Under Reexamination SATO ET AL.	
	Examiner Chuc D. Tran		Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0203529	10-2004	Hong et al.	455/090.3
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NON-PATENT DOCUMENTS

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